

**TOSHIBA****TCD1702C**

TENTATIVE

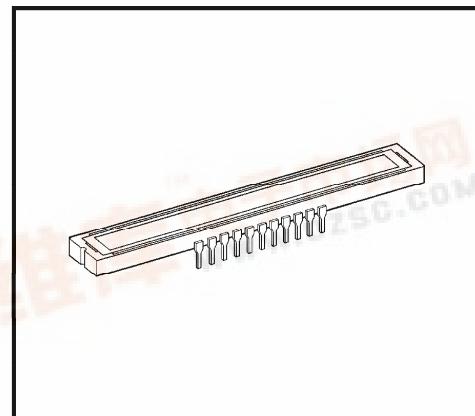
TOSHIBA CCD LINEAR IMAGE SENSOR CCD(Charge Coupled Device)

**T C D 1 7 0 2 C**

The TCD1702C is a high sensitive and low dark current 7500 elements CCD image sensor.

The sensor is designed for facsimile, imagescanner and OCR.

The device contains a row of 7500 elements photodiodes which provide a 24 lines / mm (600DPI) across a A3 size paper. The device is operated by 5V (pulse), and 12V power supply.



Weight : 6.6g (Typ.)

#### FEATURES

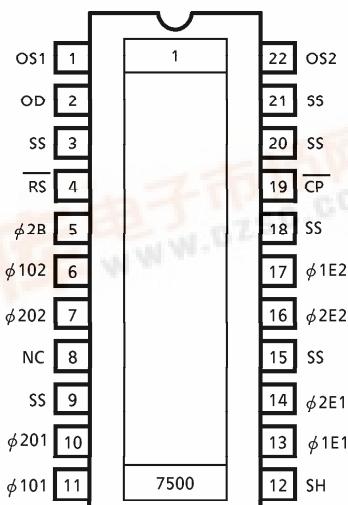
- Number of Image Sensing Elements : 7500 elements
- Image Sensing Element Size : 7 $\mu\text{m}$  by 7 $\mu\text{m}$  on 7 $\mu\text{m}$  centers
- Photo Sensing Region : High sensitive and low voltage dark signal pn photodiode
- Clock : 2 phase (5V)
- Package : 22pin DIP

#### MAXIMUM RATINGS (Note 1)

CHARACTERISTIC	SYMBOL	RATING	UNIT
Clock Pulse Voltage	V <sub>φ</sub>		
Shift Pulse Voltage	V <sub>SH</sub>	-0.3~8	V
Reset Pulse Voltage	V <sub>RS</sub>		
Clamp Pulse Voltage	V <sub>CP</sub>		
Power Supply Voltage	V <sub>OD</sub>	-0.3~15	
Operating Temperature	T <sub>opr</sub>	-25~60	°C
Storage Temperature	T <sub>stg</sub>	-40~100	°C

(Note 1) All voltage are with respect to SS terminals (Ground).

#### PIN CONNECTIONS

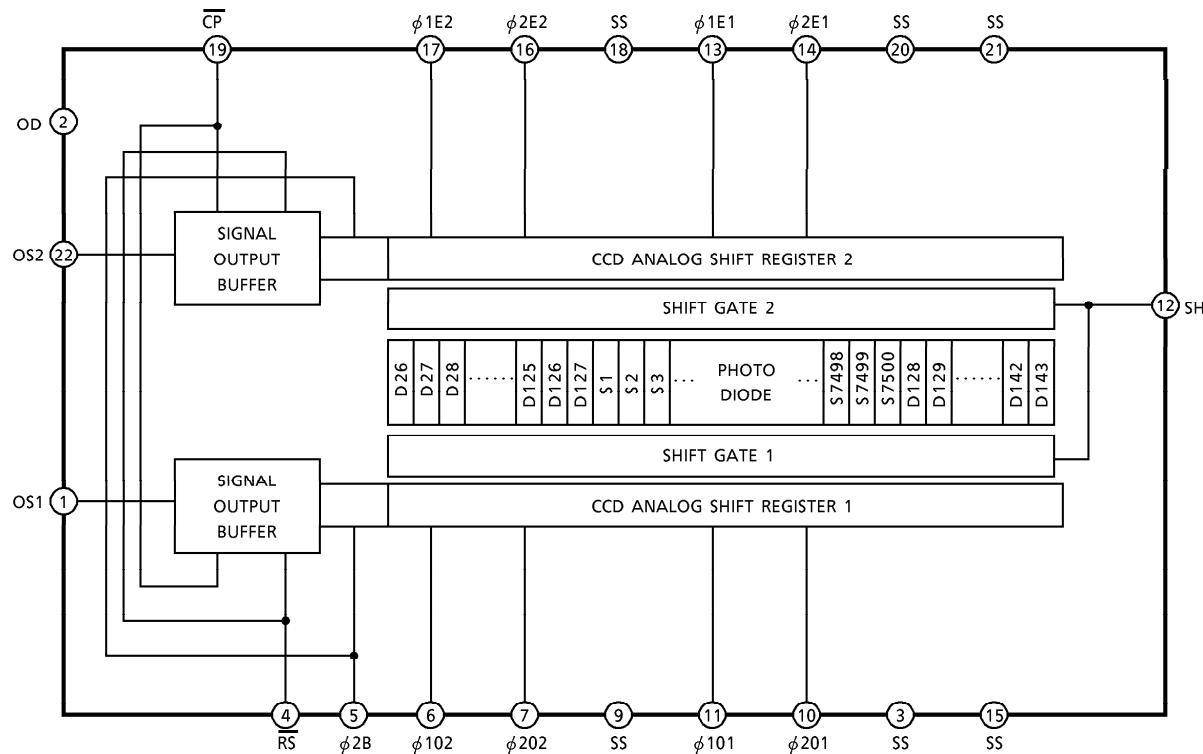


(TOP VIEW)

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## CIRCUIT DIAGRAM



## PIN NAME

$\phi 1E, O$	Clock (Phase 1)
$\phi 2E, O$	Clock (Phase 2)
$\phi 2B$	Final Stage Clock (Phase 2)
SH	Shift Gate
RS	Reset Gate
CP	Clamp Gate
OS1	Signal Output 1
OS2	Signal Output 2
OD	Power
SS	Ground
NC	Non Connection

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**OPTICAL / ELECTRICAL CHARACTERISTICS**

(Ta = 25°C, V<sub>OD</sub> = 12V, V<sub>φ</sub> = V<sub>SH</sub> = V<sub>RS</sub> = V<sub>CP</sub> = 5V, f<sub>φ</sub> = 1MHz,  
t<sub>INT</sub> (INTEGRATION TIME) = 10ms, LIGHT SOURCE = DAYLIGHT FLUORESCENT LAMP  
LOAD RESISTANCE = 100kΩ)

CHARACTERISTIC	SYMBOL	MIN.	TYP.	MAX.	UNIT	NOTE
Sensitivity	R	7.2	9	10.8	V / lx·s	
Photo Response Non Uniformity	PRNU	—	—	10	%	(Note 2)
	PRNU (3)	—	4	8	mV	(Note 8)
Saturation Output Voltage	V <sub>SAT</sub>	1.5	2	—	V	(Note 3)
Saturation Exposure	SE	0.14	0.22	—	lx·s	(Note 4)
Dark Signal Voltage	V <sub>DRK</sub>	—	1	2.5	mV	(Note 5)
Dark Signal Non Uniformity	DSNU	—	1	2.5	mV	(Note 5)
DC Power Dissipation	P <sub>D</sub>	—	300	364	mW	
Total Transfer Efficiency	TTE	92	—	—	%	
Output Impedance	Z <sub>O</sub>	—	0.5	1	kΩ	
Dynamic Range	DR	—	2000	—	—	(Note 6)
DC Signal Output Voltage	V <sub>OS1</sub>	3.5	4.5	6	V	(Note 7)
	V <sub>OS2</sub>	3.5	4.5	6	V	(Note 7)
DC Differential Error Voltage	V <sub>OS1</sub> -V <sub>OS2</sub>	—	—	300	mV	

(Note 2) Measured at 50% of SE (Typ.)

$$\text{Definition of PRNU : PRNU} = \frac{\Delta\chi}{\bar{\chi}} \times 100 (\%)$$

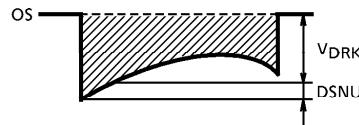
Where  $\bar{\chi}$  is average of total signal outputs and  $\Delta\chi$  is maximum deviation from  $\bar{\chi}$  under uniform illumination. (Channel 1)

In the case of 3750 elements (Channel 2), the condition is the same as above too.

(Note 3) V<sub>SAT</sub> is defined as minimum saturation output voltage of all effective pixels.

$$(Note 4) \text{ Definition of SE : SE} = \frac{V_{SAT}}{R} \text{ (lx·s)}$$

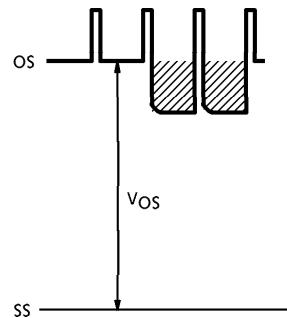
- (Note 5)  $V_{DRK}$  is defined as average dark signal voltage of all effective pixels.  
 $DSNU$  is defined as different voltage between  $V_{DRK}$  and  $V_{MDK}$  when  $V_{MDK}$  is maximum dark signal voltage.



(Note 6) Definition of DR :  $DR = \frac{V_{SAT}}{V_{DRK}}$

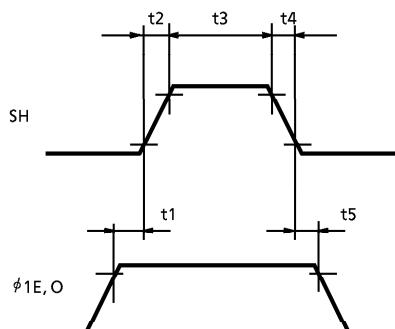
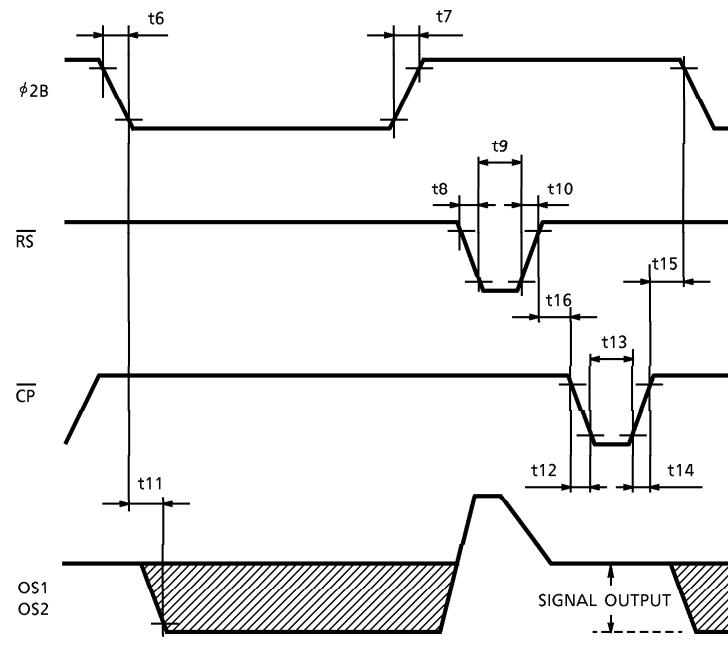
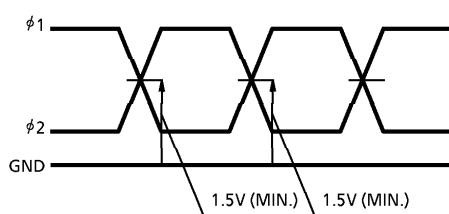
$V_{DRK}$  is proportional to  $t_{INT}$  (Integration Time).  
So the shorter  $t_{INT}$  condition makes wider DR values.

- (Note 7) DC signal output voltage and DC compensation output voltage are defined as follows:



- (Note 8) PRNU (3) is defined as maximum voltage with next pixel, where measured 5% of SE (Typ.)

## TIMING REQUIREMENTS

 $\text{SH}, \phi 1$  Timing $\phi 2, \overline{\text{RS}}, \overline{\text{CP}}, \text{OS}$  Timing $\phi 1, \phi 2$  Cross Point

CHARACTERISTIC	SYMBOL	MIN.	TYP. (Note 9)	MAX.	UNIT
Pulse Timing of SH and $\phi 10, E$	t <sub>1</sub> , t <sub>5</sub>	150	300	—	ns
SH Pulse Rise Time, Fall Time	t <sub>2</sub> , t <sub>4</sub>	0	50	—	ns
SH Pulse Width	t <sub>3</sub>	500	1000	—	ns
$\phi 2$ Pulse Rise Time, Fall Time	t <sub>6</sub> , t <sub>7</sub>	0	100	—	ns
$\overline{\text{RS}}$ Pulse Rise Time, Fall Time	t <sub>8</sub> , t <sub>10</sub>	0	20	—	ns
$\overline{\text{RS}}$ Pulse Width	t <sub>9</sub>	20	250	—	ns
Video Data Delay Time (Note 10)	t <sub>11</sub>	—	20	—	ns
$\overline{\text{CP}}$ Pulse Rise Time, Fall Time	t <sub>12</sub> , t <sub>14</sub>	0	20	—	ns
$\overline{\text{CP}}$ Pulse Width	t <sub>13</sub>	20	—	—	ns
Pulse Timing of $\phi 2B$ and $\overline{\text{CP}}$	t <sub>15</sub>	0	—	—	ns
Pulse Timing of $\overline{\text{RS}}$ and $\overline{\text{CP}}$	t <sub>16</sub>	0	—	—	ns

(Note 9) TYP. is the case of  $f_{\overline{\text{RS}}} = 1.0\text{MHz}$ (Note 10) Load Resistance is  $100\text{k}\Omega$

## OPERATING CONDITION

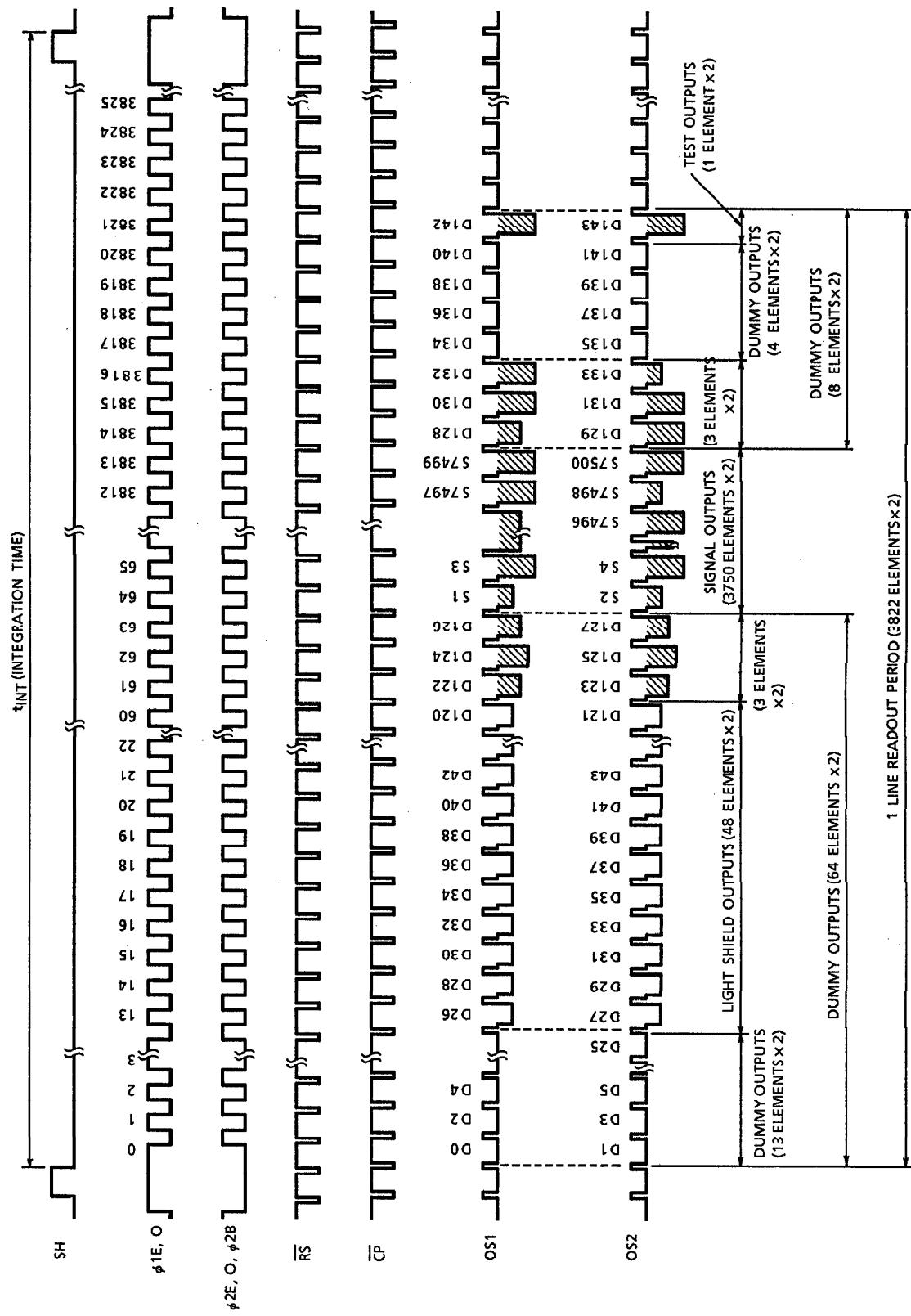
CHARACTERISTIC		SYMBOL	MIN.	TYP.	MAX.	UNIT
Clock Pulse Voltage	"H" Level	$V_{\phi}1E, O$	4.5	5	5.5	V
	"L" Level	$V_{\phi}2E, O$	0	—	0.5	
Final Stage Clock Voltage	"H" Level	$V_{\phi}2B$	4.5	5	5.5	V
	"L" Level		0	—	0.5	
Shift Pulse Voltage	"H" Level	$V_{SH}$	$V_{\phi}E, 0''H'' - 0.5$	$V_{\phi}E, 0''H''$	$V_{\phi}E, 0''H''$	V
	"L" Level		0	—	0.5	
Reset Pulse Voltage	"H" Level	$V_{RS}$	4.5	5	5.5	V
	"L" Level		0	—	0.5	
Clamp Pulse Voltage	"H" Level	$V_{CP}$	4.5	5	5.5	V
	"L" Level		0	—	0.5	
Power Supply Voltage		$V_{OD}$	11.4	12	13	V

(Note)  $V_{\phi}E, 0''H''$  means the value of high level voltage at  $V_{\phi}E, 0$ , when SH pulse is high level.

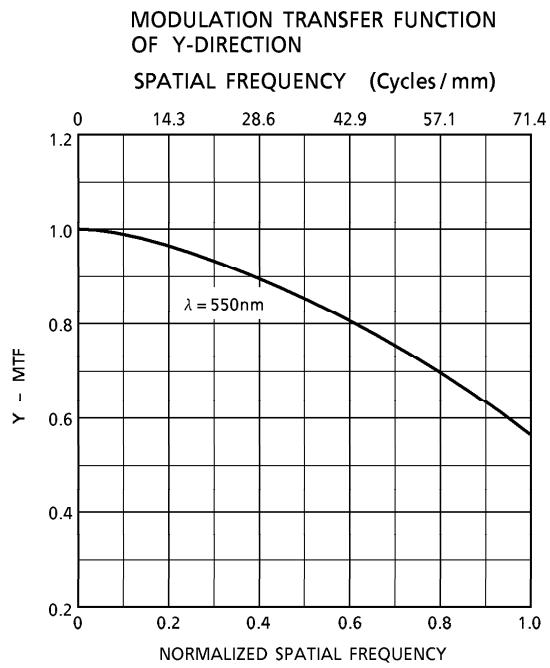
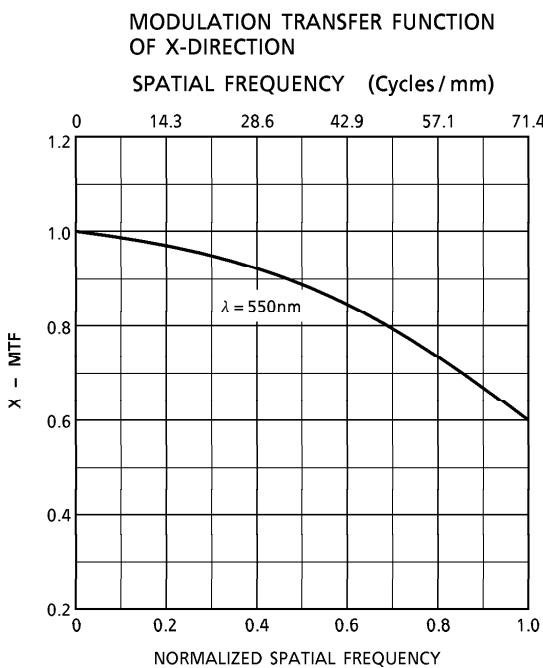
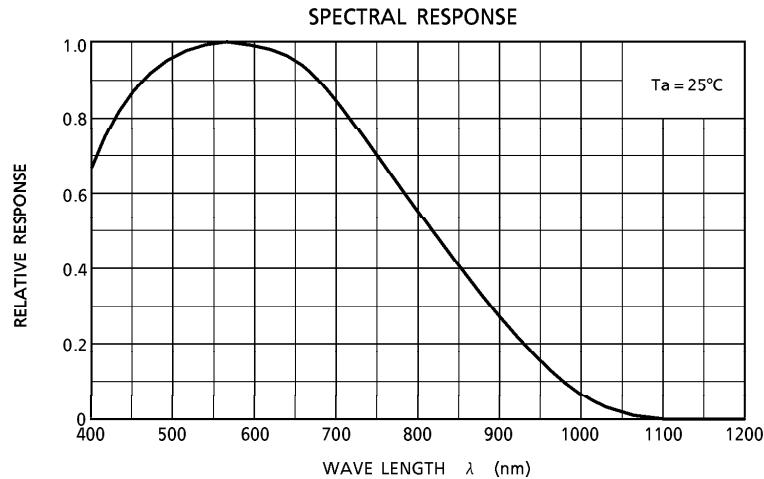
CLOCK CHARACTERISTICS ( $T_a = 25^\circ C$ )

CHARACTERISTIC	SYMBOL	MIN.	TYP.	MAX.	UNIT
Clock Pulse Frequency	$f_{\phi}$	—	1	10	MHz
Reset Pulse Frequency	$f_{RS}$	—	1	10	MHz
Clock Capacitance	$C_{\phi}E$	—	350	450	pF
	$C_{\phi}O$	—	350	450	pF
Final Stage Clock Capacitance	$C_{\phi}B$	—	10	20	pF
Shift Gate Capacitance	$C_{SH}$	—	350	450	pF
Reset Gate Capacitance	$C_{RS}$	—	10	20	pF
Clamp Gate Capacitance	$C_{CP}$	—	10	20	pF

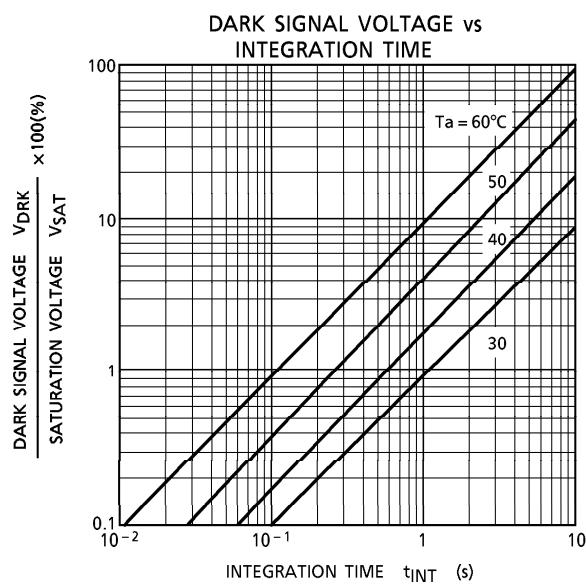
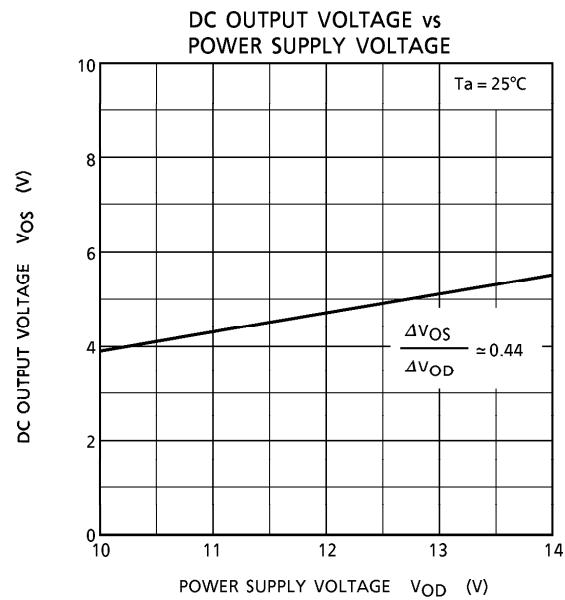
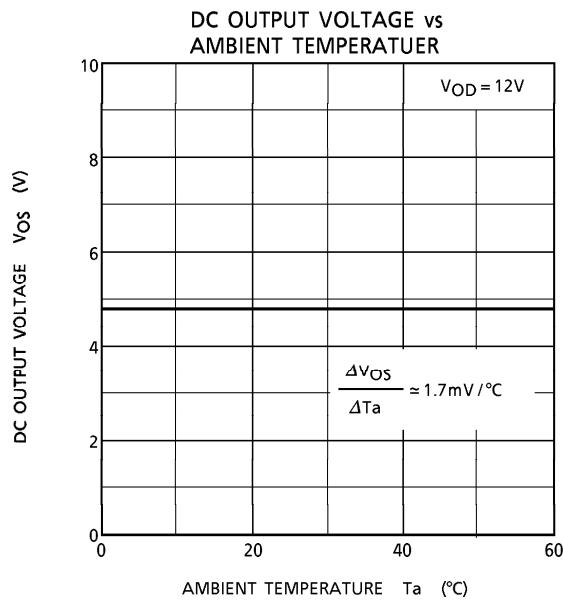
## TIMING CHART



## TYPICAL PERFORMANCE CURVES



## TYPICAL PERFORMANCE CURVES (Cont'd)



**CAUTION****1. Window Glass**

The dust and stain on the glass window of the package degrade optical performance of CCD sensor. Keep the glass window clean by saturating a cotton swab in alcohol and lightly wiping the surface, and allow the glass to dry by blowing with filtered dry N<sub>2</sub>.

Care should be taken to avoid mechanical or thermal shock because the glass window is easily to damage.

**2. Electrostatic Breakdown**

Store in shorting clip or in conductive foam to avoid electrostatic breakdown.

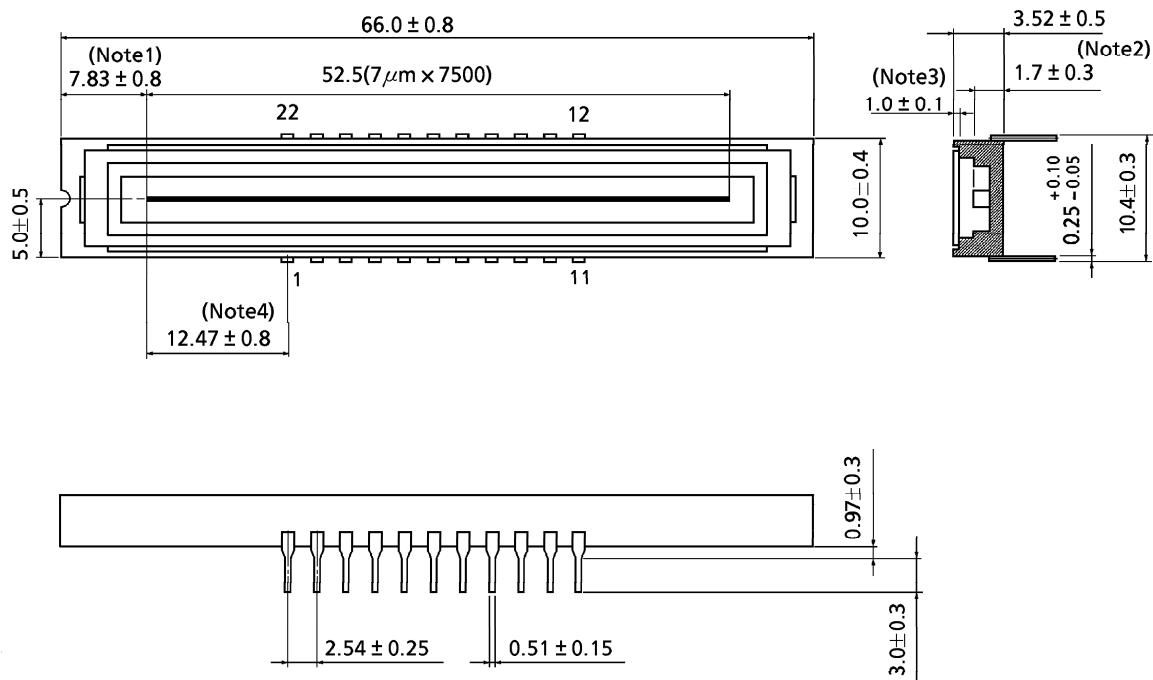
**3. Incident Light**

CCD sensor is sensitive to infrared light.

Note that infrared light component degrades resolution and PRNU of CCD sensor.

## OUTLINE DRAWING

Unit in mm



(Note 1) No. 1 SENSOR ELEMENT (S1) TO EDGE OF PACKAGE.

(Note 2) TOP OF CHIP TO BOTTOM OF PACKAGE.

(Note 3) GLASS THICKNESS ( $n = 1.5$ )

(Note 4) No. 1 SENSOR ELEMENT (S1) TO CENTER OF No. 1 PIN.

Weight : 6.6g (Typ.)